

## 1. Side-channel analysis-based detection approach of hardware Trojans

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**Abstract:** During the fabrication of integrated circuit (IC) chips in untrusted foundries, malicious circuits may be inserted as hardware Trojans, which results in a significant risk of trustworthiness and reliability degradation of the chips. As such Trojan circuits are difficult to detect using conventional strategies, a nondestructive side-channel analysis-based detection approach is proposed, which employs the algorithm of singular value decomposition to analyze and statistically process the transient power of IC chips. Validation results of the approach on FPGA chips show that, even in the presence of big noise and process variation, the proposed approach is effective in detecting the hardware Trojans that are 2 orders of magnitude smaller than the original circuit.

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**Main heading:** Hardware

**Controlled terms:** Degradation - Field programmable gate arrays (FPGA) - Singular value decomposition

**Uncontrolled terms:** Detection approach - FPGA chips - IC chips - Integrated circuit chips - Non destructive - Orders of magnitude - Process Variation - Reliability degradation - Side-channel - Side-channel analysis - Trojans - Validation results

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